

<b>Notice of References Cited</b>	Application/Control No. 10/063,793	Applicant(s)/Patent Under Reexamination CHEN ET AL.	
	Examiner John B. Vigushin	Art Unit 2841	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2004/0014317 A1	01-2004	Sakamoto et al.	438/689
	B	US-2003/0134455 A1	07-2003	Cheng et al.	438/125
	C	US-6,274,391 B1	08-2001	Wachtler et al.	438/6
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
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**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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